

<b>Notice of References Cited</b>	Application/Control No. 10/562,406	Applicant(s)/Patent Under Reexamination LAVEDAN, CHRISTIAN NICOL	
	Examiner Sean E. Aeder, Ph.D.	Art Unit 1642	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Kim et al (2002, JAMA, 287(13): abstract)
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